

DATA SHEET

ARRAY CHIP RESISTORS

YC324 (8Pin/4R; Pb Free)

5%, 1%
sizes 1220



SCOPE

This specification describes YC324 series chip resistor arrays with lead-free terminations made by thick film process.

ORDERING INFORMATION

Part number is identified by the series, size, tolerance, packing type, temperature coefficient, taping reel and resistance value.

YAGEO ORDERING CODE

CTC CODE

YC324 - X X X XX XXXX L
 (1) (2) (3) (4) (5) (6)

(1) TOLERANCE

F = ±1%

J = ±5%

(2) PACKAGING TYPE

K = Embossed taping reel

(3) TEMPERATURE COEFFICIENT OF RESISTANCE

- = Base on spec

(4) TAPING REEL

07 = 7 inch dia. Reel

(5) RESISTANCE VALUE

56R, 560R, 5K6, 56K, 1M

(6) RESISTOR TERMINATIONS

L = Lead free terminations (pure Tin)

ORDERING EXAMPLE

The ordering code of a YC324 convex chip resistor array, value 1,000 Ω with ±5% tolerance, supplied in 7-inch tape reel is: YC324-JK-071KL.

NOTE

1. The "L" at the end of the code is only for ordering. On the reel label, the standard CTC will be mentioned an additional stamp "LFP"= lead free production.
2. Products with lead in terminations fulfil the same requirements as mentioned in this datasheet.
3. Products with lead in terminations will be phased out in the coming months (before July 1st, 2006)

MARKING

YC324



Fig. 1 Value = 240 KΩ

E-24 series: 3 digits

First two digits for significant figure and 3rd digit for number of zeros

For marking codes, please see EIA-marking code rules in data sheet “Chip resistors marking”.

CONSTRUCTION

The resistors are constructed out of a high-grade ceramic body. Internal metal electrodes are added at each end and connected by a resistive paste. The composition of the paste is adjusted to give the approximate required resistance and laser cutting of this resistive layer that achieves tolerance trims the value. The resistive layer is covered with a protective coat. Finally, the eight external terminations (pure Tin) are added. See fig. 2.

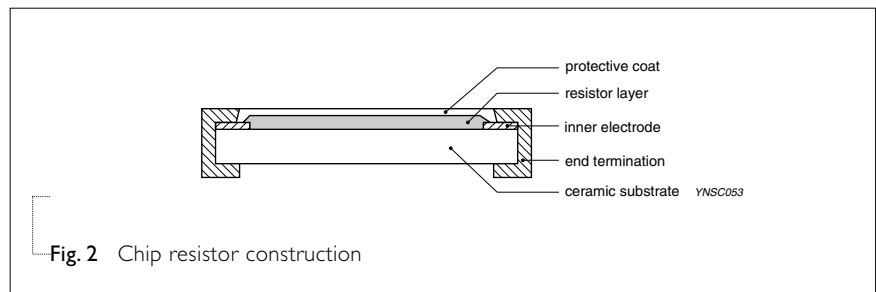


Fig. 2 Chip resistor construction

DIMENSIONS

Table I

TYPE	YC324
B (mm)	0.50 ±0.20
H (mm)	1.10 ±0.15
P (mm)	1.27 ±0.05
L (mm)	5.08 ±0.20
H ₂ (mm)	0.90 ±0.15
T (mm)	0.60 ±0.10
W ₁ (mm)	0.50 ±0.15
W ₂ (mm)	3.20 ±0.20

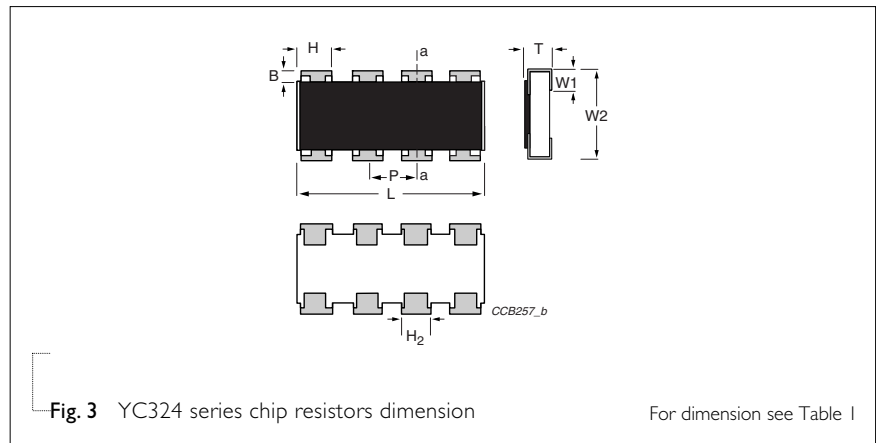


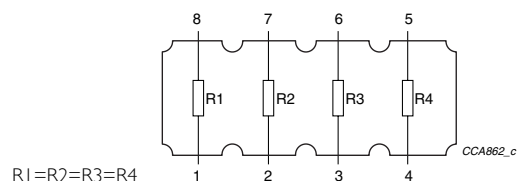
Fig. 3 YC324 series chip resistors dimension

For dimension see Table I

SCHEMATIC

For dimension see Fig. 3 and Table I

Fig. 4 Equivalent circuit diagram



R1=R2=R3=R4

ELECTRICAL CHARACTERISTICS

Table 2

CHARACTERISTICS	YC324 1/8 W
Operating Temperature Range	-55 °C to +155 °C
Maximum Working Voltage	200 V
Maximum Overload Voltage	500 V
Dielectric Withstanding Voltage	500 V
Number of Resistors	4
Resistance Range	5% (E24) 10 Ω to 1 MΩ
	1% (E24/E96) 10 Ω to 1 MΩ
Temperature Coefficient	±200 ppm/°C

FOOTPRINT AND SOLDERING PROFILES

For recommended footprint and soldering profiles, please see the special data sheet “Chip resistors mounting”.

ENVIRONMENTAL DATA

For material declaration information (IMDS-data) of the products, please see the separated info “Environmental data” conformed to EU RoHS.

PACKING STYLE AND PACKAGING QUANTITY

Table 3 Packing style and packaging quantity

PRODUCT TYPE	PACKING STYLE	REEL DIMENSION	QUANTITY PER REEL
YC324	Embossed taping reel (K)	7" (178 mm)	4,000 units

NOTE

- For embossed tape and reel specification/dimensions, please see the special data sheet “Packing” document.

FUNCTIONAL DESCRIPTION

POWER RATING

YC324 rated power at 70°C is 1/8 W

RATED VOLTAGE

The DC or AC (rms) continuous working voltage corresponding to the rated power is determined by the following formula:

$$V = \sqrt{P \times R}$$

Where

V = Continuous rated DC or AC (rms) working voltage (V)

P = Rated power (W)

R = Resistance value (Ω)

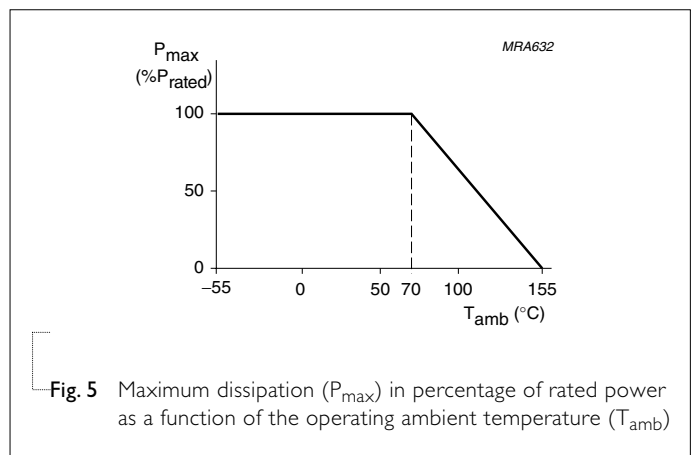


Fig. 5 Maximum dissipation (P_{max}) in percentage of rated power as a function of the operating ambient temperature (T_{amb})

TESTS AND REQUIREMENTS

Table 4 Test condition, procedure and requirements

TEST	TEST METHOD	PROCEDURE	REQUIREMENTS
Temperature Coefficient of Resistance (T.C.R.)	MIL-STD-202F-method 304;	At +25/-55 °C and +25/+125 °C	Refer to table 2
	JIS C 5202-4.8	<p>Formula:</p> $T.C.R = \frac{R_2 - R_1}{R_1(t_2 - t_1)} \times 10^6 \text{ (ppm/°C)}$ <p>Where $t_1 = +25 \text{ °C}$ or specified room temperature $t_2 = -55 \text{ °C}$ or +125 °C test temperature $R_1 =$ resistance at reference temperature in ohms $R_2 =$ resistance at test temperature in ohms</p>	
Thermal Shock	MIL-STD-202F-method 107G; IEC 60115-1 4.19	At -65 (+0/-10) °C for 2 minutes and at +155 (+10/-0) °C for 2 minutes; 25 cycles	±(0.5% +0.05 Ω) for 1% tol. ±(1.0% +0.05 Ω) for 5% tol.
Low Temperature Operation	MIL-R-55342D-Para 4.7.4	At -65 (+0/-5) °C for 1 hour; RCWV applied for 45 (+5/-0) minutes	±(0.5% +0.05 Ω) for 1% tol . ±(1.0% +0.05 Ω) for 5% tol. No visible damage
Short Time Overload	MIL-R-55342D-Para 4.7.5; IEC 60115-1 4.13	2.5 × RCWV applied for 5 seconds at room temperature	±(1.0% +0.05 Ω) for 1% tol. ±(2.0% +0.05 Ω) for 5% tol. No visible damage
Insulation Resistance	MIL-STD-202F-method 302; IEC 60115-1 4.6.1.1	RCOV for 1 minute <u>Type</u> YC324 <u>Voltage (DC)</u> 500 V	≥10 GΩ
Dielectric Withstand Voltage	MIL-STD-202F-method 301; IEC 60115-1 4.6.1.1	Maximum voltage (V_{rms}) applied for 1 minute <u>Type</u> YC324 <u>Voltage (AC)</u> 500 V_{rms}	No breakdown or flashover
Resistance to Soldering Heat	MIL-STD-202F-method 210C; IEC 60115-1 4.18	Unmounted chips; 260 ±5 °C for 10 ±1 seconds	±(0.5% +0.05 Ω) for 1% tol. ±(1.0% +0.05 Ω) for 5% tol. No visible damage
Life	MIL-STD-202F-method 108A; IEC 60115-1 4.25.1	At 70 ±2 °C for 1,000 hours; RCWV applied for 1.5 hours on and 0.5 hour off	±(1% +0.05 Ω) for 1% tol. ±(3% +0.05 Ω) for 5% tol.

TEST	TEST METHOD	PROCEDURE	REQUIREMENTS														
Solderability	MIL-STD-202F-method 208A; IEC 60115-1 4.17	Solder bath at 245 ±3 °C Dipping time: 2 ±0.5 seconds	Well tinned (≥95% covered) No visible damage														
Bending Strength	JIS C 5202.6.14; IEC 60115-1 4.15	Resistors mounted on a 90 mm glass epoxy resin PCB (FR4) Bending: 1 mm	±(1.0% +0.05 Ω) for 1% tol. ±(1.0% +0.05 Ω) for 5% tol. No visible damage														
Resistance to Solvent	MIL-STD-202F-method 215; IEC 60115-1 4.29	Isopropylalcohol (C ₃ H ₇ OH) or dichloromethane (CH ₂ Cl ₂) followed by brushing	No smeared														
Noise	JIS C 5202 5.9; IEC 60115-1 4.12	Maximum voltage (V _{rms}) applied.	<table border="1"> <thead> <tr> <th>Resistors range</th> <th>Value</th> </tr> </thead> <tbody> <tr> <td>R < 100 Ω</td> <td>10 dB</td> </tr> <tr> <td>100 Ω ≤ R < 1 KΩ</td> <td>20 dB</td> </tr> <tr> <td>1 KΩ ≤ R < 10 KΩ</td> <td>30 dB</td> </tr> <tr> <td>10 KΩ ≤ R < 100 KΩ</td> <td>40 dB</td> </tr> <tr> <td>100 KΩ ≤ R < 1 MΩ</td> <td>46 dB</td> </tr> <tr> <td>1 MΩ ≤ R ≤ 22 MΩ</td> <td>48 dB</td> </tr> </tbody> </table>	Resistors range	Value	R < 100 Ω	10 dB	100 Ω ≤ R < 1 KΩ	20 dB	1 KΩ ≤ R < 10 KΩ	30 dB	10 KΩ ≤ R < 100 KΩ	40 dB	100 KΩ ≤ R < 1 MΩ	46 dB	1 MΩ ≤ R ≤ 22 MΩ	48 dB
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Humidity (steady state)	JIS C 5202 7.5; IEC 60115-8 4.24.8	1,000 hours; 40 ±2 °C; 93(+2/-3)% RH RCWV applied for 1.5 hours on and 0.5 hour off	±(0.5% +0.05 Ω) for 1% tol. ±(2.0% +0.05 Ω) for 5% tol.														
Leaching	EIA/IS 4.13B; IEC 60115-8 4.18	Solder bath at 260 ±5 °C Dipping time: 30 ±1 seconds	No visible damage														
Intermittent Overload	JIS C 5202 5.8	At room temperature; 2.5 × RCWV applied for 1 second on and 25 seconds off; total 10,000 cycles	±(1.0% +0.05 Ω) for 1% tol. ±(2.0% +0.05 Ω) for 5% tol.														
Resistance to Vibration	On request	On request															
Moisture Resistance Heat	MIL-STD-202F-method 106F; IEC 60115-1 4.24.2	42 cycles; total 1,000 hours Shown as Fig. 6	±(0.5% +0.05Ω) for 1% tol. ±(2.0% +0.05Ω) for 5% tol. No visible damage														

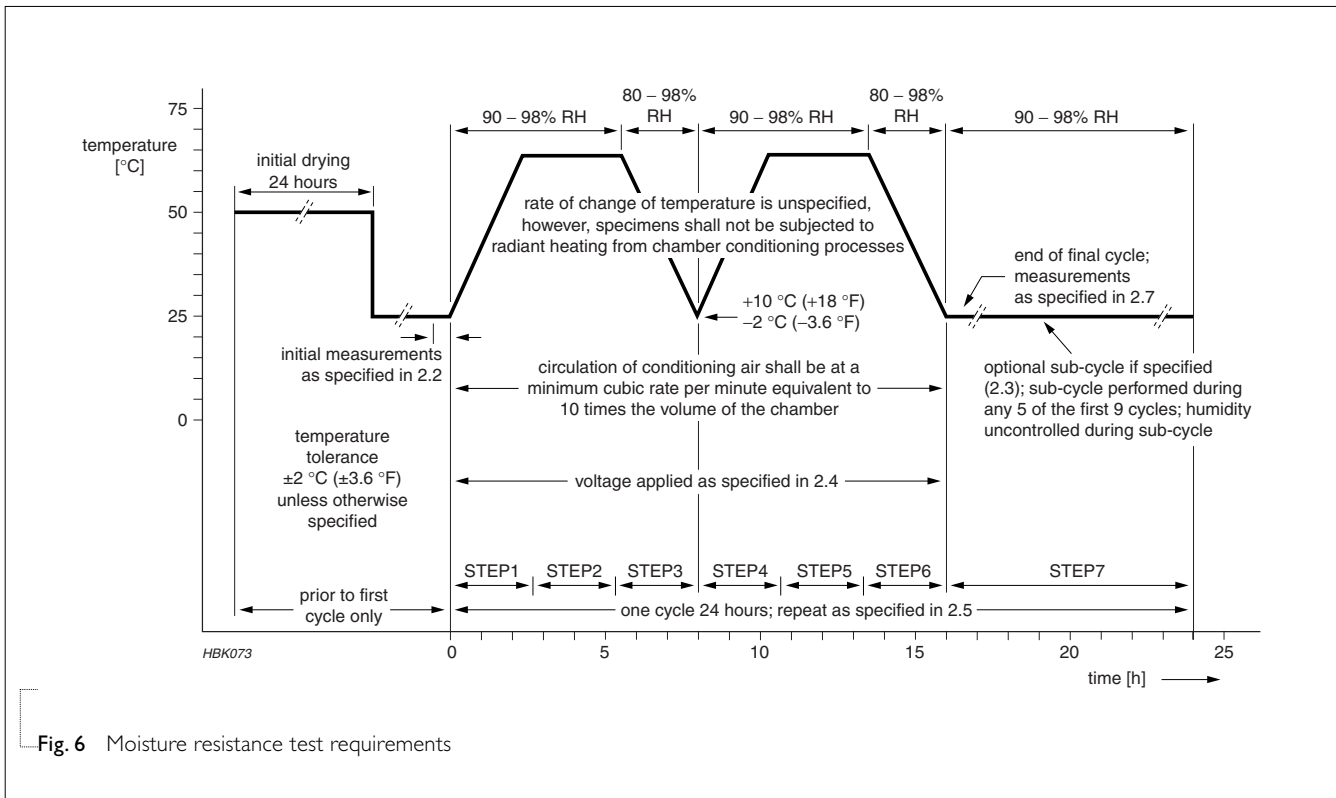


Fig. 6 Moisture resistance test requirements

REVISION HISTORY

REVISION	DATE	CHANGE NOTIFICATION	DESCRIPTION
Version 1	Feb 22, 2005	-	- Test method and procedure updated
Version 0	Nov. 10, 2003	-	- First issue of PbFree specification